TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74HC573AP,TC74HC573AF

Octal D-Type Latch with 3-State Output

The TC74HC573A is a high speed CMOS OCTAL LATCH with 3-STATE OUTPUT fabricated with silicon gate $\rm C^2MOS$ technology.

It achieves the high speed operation similar to equivalent LSTTL while maintaining the CMOS low power dissipation.

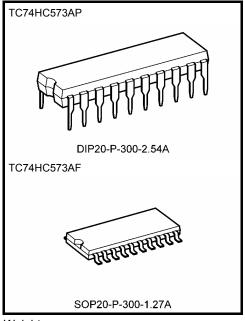
Its 8-bit D-type latche is controlled by a latch enable input (LE) and an output enable input (\overline{OE}).

When the $\overline{\mbox{OE}}$ input is high, the eight outputs are in a high impedance state.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

Features

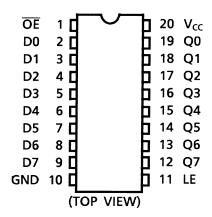
- High speed: $t_{pd} = 13 \text{ ns (typ.)}$ at $V_{CC} = 5 \text{ V}$
- Low power dissipation: $I_{CC} = 4 \mu A \text{ (max)}$ at $T_a = 25^{\circ}C$
- High noise immunity: $V_{NIH} = V_{NIL} = 28\% V_{CC}$ (min)
- Output drive capability: 15 LSTTL loads
- Symmetrical output impedance: $|I_{OH}| = I_{OL} = 6 \text{ mA (min)}$
- Balanced propagation delays: $t_{pLH} \approx t_{pHL}$
- Wide operating voltage range: V_{CC} (opr) = 2 to 6 V
- Pin and function compatible with 74LS573



Weight

DIP20-P-300-2.54A : 1.30 g (typ.) SOP20-P-300-1.27A : 0.22 g (typ.)

Pin Assignment



IEC Logic Symbol

OE (1) LE (11)	EN C 1	
$ \begin{array}{c} D0 \\ \hline (2) \\ (3) \\ (4) \\ (5) \\ (5) \\ (6) \\ (7) \\ (8) \\ (9) \\ D7 \end{array} $	1D ▷ ♡	(19) Q0 (18) Q1 (17) Q2 (16) Q3 (15) Q4 (14) Q5 (13) Q6 (12) Q7

Truth Table

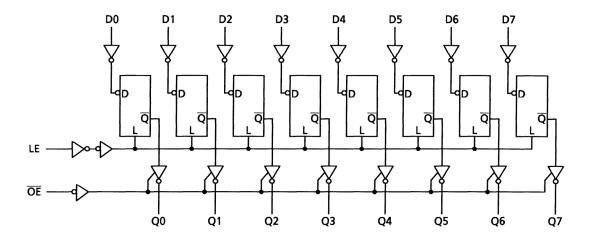
	Output		
ŌĒ	LE	D	Q
Н	Х	Х	HZ
L	L	Х	Qn
L	Н	L	L
L	Н	Н	Н

X: Don't care

HZ: High impedance

 $\mathsf{Q}_{\mathsf{n}} . \; \mathsf{Q}$ outputs are latched at the time when the LE input is taken to a low logic level.

System Diagram



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Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	–0.5 to 7	V
DC input voltage	V _{IN}	−0.5 to V _{CC} + 0.5	V
DC output voltage	V _{OUT}	-0.5 to V _{CC} + 0.5	V
Input diode current	I _{IK}	±20	mA
Output diode current	lok	±20	mA
DC output current	lout	±35	mA
DC V _{CC} /ground current	Icc	±75	mA
Power dissipation	PD	500 (DIP) (Note 2)/180 (SOP)	mW
Storage temperature	T _{stg}	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: 500 mW in the range of Ta = -40 to $65^{\circ}C$. From Ta = 65 to $85^{\circ}C$ a derating factor of -10 mW/°C shall be applied until 300 mW.

Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage	V _{CC}	2 to 6	V
Input voltage	V _{IN}	0 to V _{CC}	V
Output voltage	V _{OUT}	0 to V _{CC}	٧
Operating temperature	T _{opr}	−40 to 85	°C
		0 to 1000 (V _{CC} = 2.0 V)	
Input rise and fall time	t _r , t _f	0 to 500 (V _{CC} = 4.5 V)	ns
		0 to 400 (V _{CC} = 6.0 V)	

Note: The operating ranges must be maintained to ensure the normal operation of the device.

Unused inputs must be tied to either VCC or GND.

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Electrical Characteristics

DC Characteristics

Characteristics	Symbol	Test Condition			-	Ta = 25°C		Ta = -40 to 85°C		Unit
	.,				Min	Тур.	Max	Min	Max	
				2.0	1.50	_	_	1.50	_	
High-level input voltage	V_{IH}		_	4.5	3.15	_		3.15	_	V
				6.0	4.20	_	_	4.20	_	
				2.0	_	_	0.50	_	0.50	
Low-level input voltage	V_{IL}		_	4.5	_	_	1.35	_	1.35	V
				6.0	_	_	1.80	_	1.80	
				2.0	1.9	2.0	_	1.9	_	
	V _{OH}		$I_{OH} = -20 \mu A$	4.5	4.4	4.5	_	4.4	_	
High-level output voltage		V _{IN} = V _{IH} or V _{IL}		6.0	5.9	6.0	_	5.9	_	V
			$I_{OH} = -6 \text{ mA}$	4.5	4.18	4.31	_	4.13	_	
			$I_{OH} = -7.8 \text{ mA}$	6.0	5.68	5.80	_	5.63	_	
				2.0	_	0.0	0.1		0.1	
			$I_{OL} = 20 \mu A$	4.5	_	0.0	0.1	_	0.1	
Low-level output voltage	V_{OL}	V _{IN} = V _{IH} or V _{IL}		6.0	_	0.0	0.1	_	0.1	V
			I _{OL} = 6 mA	4.5	_	0.17	0.26	_	0.33	
			I _{OL} = 7.8 mA	6.0		0.18	0.26	_	0.33	
3-state output off-state current	I _{OZ}	$V_{IN} = V_{IH}$ or V_{IL} $V_{OUT} = V_{CC}$ or GND		6.0	_	_	±0.5	_	±5.0	μА
Input leakage current	I _{IN}	V _{IN} = V _{CC} or GND		6.0	_	_	±0.1	_	±1.0	μА
Quiescent supply current	Icc	V _{IN} = V _{CC} or	r GND	6.0	_	_	4.0	_	40.0	μА

Timing Requirements (input: $t_r = t_f = 6 \text{ ns}$)

Characteristics	Symbol	Test Condition		Ta = 25°C		Ta = -40 to 85°C	Unit	
			V _{CC} (V)	Тур.	Limit	Limit		
Minimum nulao width			2.0	_	75	95		
Minimum pulse width	t _{W (H)}	_	4.5	_	15	19	ns	
(LE)			6.0	_	13	16		
Minimum set-up time			2.0	_	50	65		
· ·	ts	_	4.5	_	10	13	ns	
(data)			6.0	_	9	11		
Minimum hold time			2.0	_	5	5		
	t _h	_	4.5	_	5	5	ns	
(data)			6.0	_	5	5		



AC Characteristics (input: $t_r = t_f = 6$ ns)

Characteristics Symbol		Test Condition			-	Га = 25°0		Ta = -40 to 85°C		Unit
5.1.a.1 d 51.51.51.51	- J20.		CL (pF)	V _{CC} (V)	Min	Тур.	Max	Min	Max	J
	t _{TLH}			2.0	_	20	60	_	75	
Output transition time	t _{THL}	_	50	4.5	_	6	12	_	15	ns
	THL			6.0	_	5	10	_	13	
				2.0	_	50	115	_	145	
			50	4.5	_	15	23	_	29	
Propagation delay time	t_{pLH}			6.0	_	13	20	_	25	ns
(LE-Q)	t_{pHL}			2.0	_	60	155		195	113
			150	4.5	_	20	31	_	39	
				6.0	_	17	26	_	33	
				2.0		42	110	_	140	
			50	4.5	_	14	22	_	28	
Propagation delay time	t_{pLH}			6.0	_	12	19	_	24	ns
(D-Q)	t_{pHL}	_		2.0	_	57	150	_	190	115
,			150	4.5	_	19	30	_	38	
				6.0	_	16	26	_	32	
				2.0	_	55	140	_	175	
			50	4.5	_	17	28	_	35	
Output enable time	t_{pZL}	$R_L = 1 k\Omega$		6.0	_	14	24	_	30	20
Output eriable time	t _{pZH}	K[= 1 K22		2.0	_	66	180	_	225	ns
			150	4.5	_	22	36	_	45	
				6.0	_	19	31	_	38	
	4 .			2.0	_	40	125	_	155	
Output disable time	t _{pLZ}	$R_L = 1 \text{ k}\Omega$	50	4.5	_	17	25	_	31	ns
	t _{pHZ}			6.0	_	15	21	_	26	
Input capacitance	C _{IN}	_		_	5	10	_	10	pF	
Output capacitance	C _{OUT}	_	_		_	10	_	_	_	pF
Power dissipation	C _{PD}					5 1				pF
capacitance	(Note)	_				51				þΓ

Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

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Average operating current can be obtained by the equation:

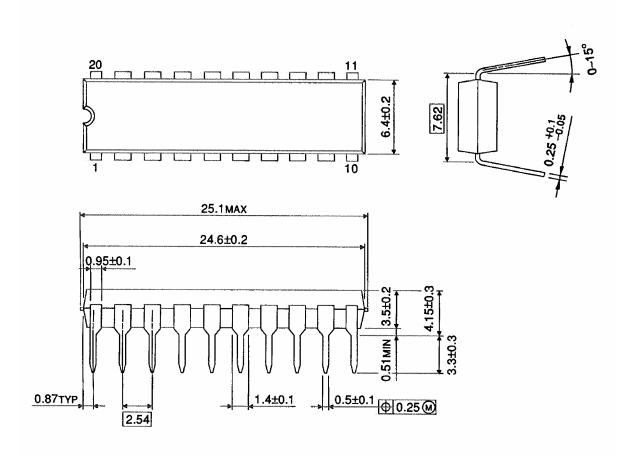
$$I_{CC}$$
 (opr) = $C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8$ (per latch)

And the total C_{PD} when n pcs. of latch operate can be gained by the following equation:

$$C_{PD}$$
 (total) = 33 + 18 · n

Package Dimensions

DIP20-P-300-2.54A Unit: mm



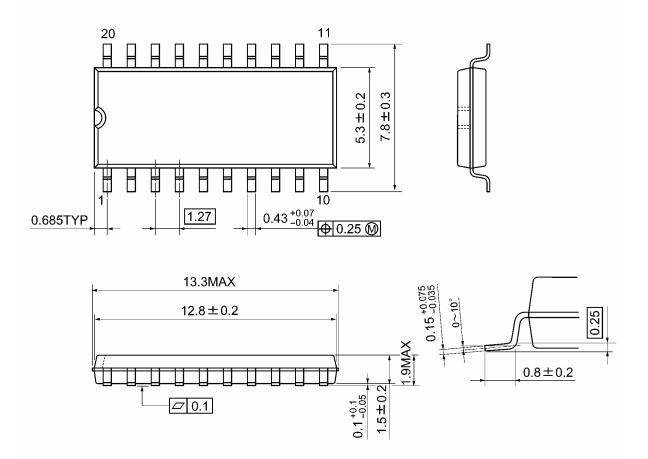
6

Weight: 1.30 g (typ.)



Package Dimensions

SOP20-P-300-1.27A Unit: mm



Weight: 0.22 g (typ.)

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20070701-EN GENERAL

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